

Enhancement Mode N-Channel Power MOSFET

 $TO-252/NMOS/500V/\pm30V/3V/5A/1.3\Omega$

Rev0.6





Enhancement Mode N-Channel Power MOSFET

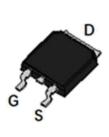
1.Features

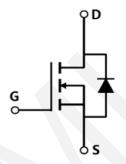
- ◆ Fast Switching
- ◆ Improved dv/dt Capability

2.Applications

- ◆ Load Switch
- PWM Application
- ♦ Power management

V _{DS}	R _{DS(on)} Typ.	I _D Max.	
500V	1.3Ω @ 10V	5A	





TO-252 Pin Description

Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP5N50KD	WP5N50	TO-252	2,500	25,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Value	Units
Drain to Source Voltage	V _{DS}	500	V
Gate to Source Voltage	V _{GS}	±30	V
Drain Current (DC)	I _D	5	А
Drain Current (Pulse), PW≤300μs	I DP	17	А
Total Dissipation	P _D	104	W
Avalanche Energy, Single Pulsed	E _{AS}	235	mJ
Junction Temperature	Tj	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to case	Rejc	1	°C/W
Junction to ambient	$R_{ heta JA}$	43	°C/W

Note 2: When mounted on 1 inch square copper board t ≤ 10sec The value in any given application depends on the user's specific board design.



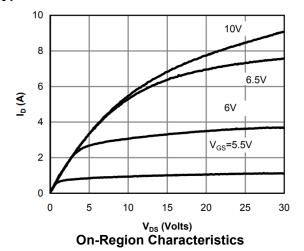
6.Electrical Characteristics at Ta=25°C (Note 3)

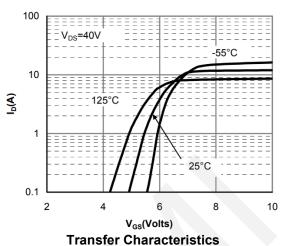
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A$, $V_{GS} = 0 V$	500	535		V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 500V, V _{GS} = 0V			1	μΑ
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±30V			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =250µA	2	3	4	V
Static Drain to Source On-State Resistance	R _{DS(on)}	I _D = 2.5A, V _{GS} = 10V	-	1.3	1.5	Ω
Input Capacitance	Ciss	V _{GS} =0V,		538		pF
Output Capacitance	Coss	V _{DS} =25V,		58		pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz		4.5		pF
Turn-ON Delay Time	t _{d(on)}			18		ns
Rise Time	t _r	V _{GS} =10V,		32		ns
Turn-OFF Delay Time	t _{d(off)}	$V_{DS} = 250V, I_{D} = 5A,$ $R_{G} = 25\Omega$		34		ns
Fall Time	t _f			22		ns
	Qg	V _{DS} = 450V,		11.5		nC
Total Gate Charge	Qgs	V _{GS} = 10V,		3.8		nC
	Q _{gd}	I _D = 5A		4.1		nC
Diode Forward Voltage	V _{FSD}	I _S = 5A, V _{GS} = 0		0.85	1.2	V

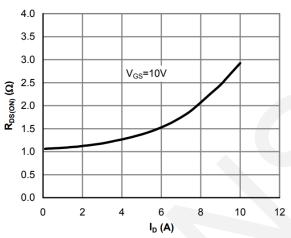
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

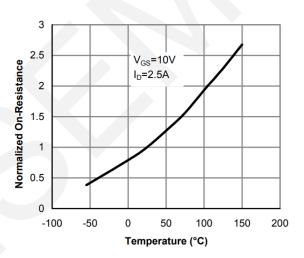


7. Typical electrical and thermal characteristics



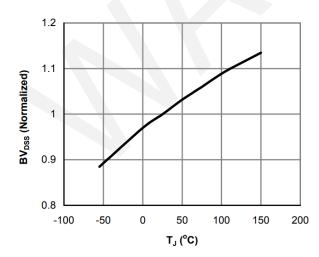


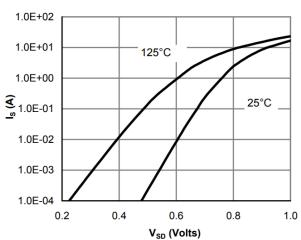




On-Resistance vs. Drain Current and Gate Voltage

On-Resistance vs. Junction Temperature

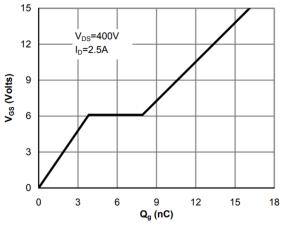


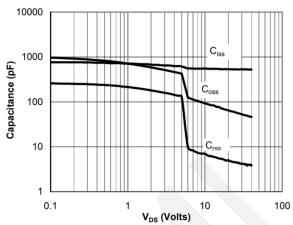


Break Down vs. Junction Temperature

Body-Diode Characteristics

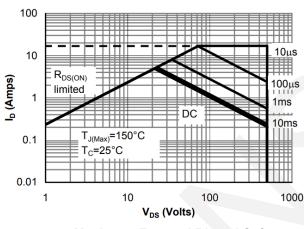


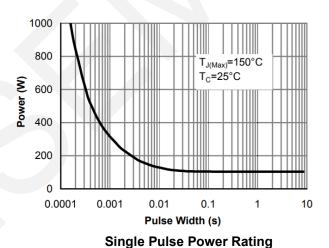




Gate-Charge Characteristics

Capacitance Characteristics

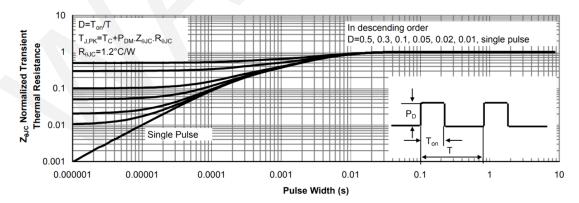




Maximum Forward Biased Safe

Junction-to-Case

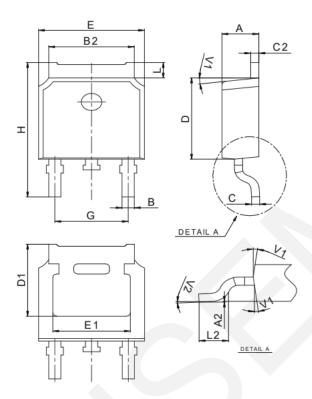
Operating Area



Normalized Maximum Transient Thermal Impedance



8.Package Dimensions



	Dimensions						
Ref.		Millimeters		Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
Α	2.10		2.50	0.083		0.098	
A2	0		0.10	0		0.004	
В	0.66		0.86	0.026		0.034	
B2	5.18		5.48	0.202		0.216	
С	0.40		0.60	0.016		0.024	
C2	0.44		0.58	0.017		0.023	
D	5.90		6.30	0.232		0.248	
D1	5.30REF			0.209REF			
E	6.40		6.80	0.252		0.268	
E1	4.63			0.182			
G	4.47		4.67	0.176		0.184	
Н	9.50		10.70	0.374		0.421	
L	1.09		1.21	0.043		0.048	
L2	1.35		1.65	0.053		0.065	
V1		7°			7°		
V2	0°		6°	0°		6°	



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